

MOS FIELD EFFECT TRANSISTOR NP90N06VLG

SWITCHING N-CHANNEL POWER MOS FET

DESCRIPTION

The NP90N06VLG is N-channel MOS Field Effect Transistor designed for high current switching applications.

ORDERING INFORMATION

PART NUMBER	LEAD PLATING	PACKING	PACKAGE		
NP90N06VLG-E1-AY Note	Dura Ca (Tia)	Tana 0500 n/mal			
NP90N06VLG-E2-AY	Pure Sn (Tin)	Tape 2500 p/reel	TO-252 (MP-3ZP) typ. 0.27 g		

Note Pb-free (This product does not contain Pb in external electrode.)

FEATURES

- Logic level
- Built-in gate protection diode
- Super low on-state resistance
- $R_{DS(on)1}$ = 7.8 m Ω MAX. (V_{GS} = 10 V, I_D = 45 A)
- $R_{DS(on)2}$ = 12.5 m Ω MAX. (V_{GS} = 4.5 V, I_D = 35 A)
- High current rating I_{D(DC)} = ±90 A
- Low input capacitance
- Ciss = 4600 pF TYP.
- Designed for automotive application and AEC-Q101 qualified

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

•		,	
Drain to Source Voltage (V _{GS} = 0 V)	Vdss	60	V
Gate to Source Voltage (VDs = 0 V)	Vgss	±20	V
Drain Current (DC) (Tc = 25°C)	ID(DC)	±90	А
Drain Current (pulse) Note1	D(pulse)	±180	А
Total Power Dissipation (Tc = 25°C)	PT1	105	W
Total Power Dissipation (T _A = 25° C)	Pt2	1.2	W
Channel Temperature	Tch	175	°C
Storage Temperature	Tstg	-55 to +175	°C
Repetitive Avalanche Current Note2	AR	32	А
Repetitive Avalanche Energy Note2	Ear	102	mJ
 Notes 1. PW ≤ 10 μs, Duty Cycle ≤ 1% 2. T_{ch} ≤ 150°C, R_G = 25 Ω 			
THERMAL RESISTANCE Channel to Case Thermal Resistance	Rth(ch-C)	1.43	°C/W

The information in this document is subject to change without notice. Before using this document, please confirm that this is the latest version. Not all products and/or types are available in every country. Please check with an NEC Electronics sales representative for availability and additional information.

125

°C/W

 $R_{th(ch-A)}$

Document No. D19794EJ1V0DS00 (1st edition) Date Published May 2009 NS Printed in Japan

Channel to Ambient Thermal Resistance

(TO-252)



© NEC Electronics Corporation 2009

90%

90%

VGS

10% 10%

toff

tr td(off) tſ

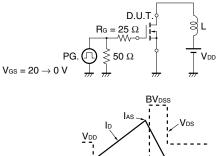
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	loss	V _{DS} = 60 V, V _{GS} = 0 V			1	μA
Gate Leakage Current	Igss	V _{GS} = ±20 V, V _{DS} = 0 V			±10	μA
Gate to Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA	1.4		2.5	V
Forward Transfer Admittance Note	y _{fs}	V _{DS} = 5 V, I _D = 45 A	30	66		S
Drain to Source On-state Resistance Note	RDS(on)1	V _{GS} = 10 V, I _D = 45 A		6.2	7.8	mΩ
	RDS(on)2	V _{GS} = 4.5 V, I _D = 35 A		7.5	12.5	mΩ
Input Capacitance	Ciss	V _{DS} = 25 V,		4600	6900	pF
Output Capacitance	Coss	V _{GS} = 0 V,		370	560	pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		220	400	pF
Turn-on Delay Time	t _{d(on)}	V _{DD} = 30 V, I _D = 45 A,		17	34	ns
Rise Time	tr	V _{GS} = 10 V,		13	33	ns
Turn-off Delay Time	t _{d(off)}	R _G = 0 Ω		76	152	ns
Fall Time	tr			7	18	ns
Total Gate Charge	QG	V _{DD} = 48 V,		90	135	nC
Gate to Source Charge	Q _{GS}	V _{GS} = 10 V,		13		nC
Gate to Drain Charge	Qgd	I _D = 90 A		26		nC
Body Diode Forward Voltage	V _{F(S-D)}	IF = 90 A, VGS = 0 V		0.9	1.5	V
Reverse Recovery Time	trr	IF = 90 A, VGS = 0 V,		38		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/ <i>µ</i> s		56		nC

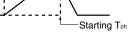
ELECTRICAL CHARACTERISTICS (TA = 25°C)

Note Pulsed test

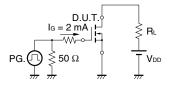
TEST CIRCUIT 1 AVALANCHE CAPABILITY

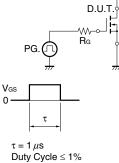
TEST CIRCUIT 2 SWITCHING TIME

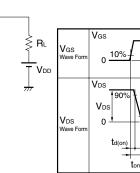




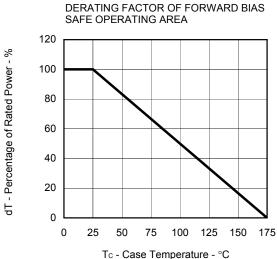
TEST CIRCUIT 3 GATE CHARGE





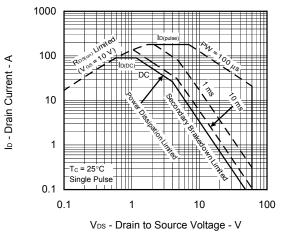


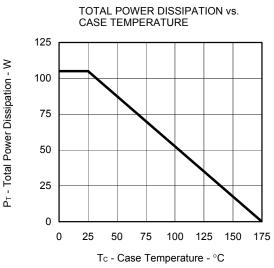
TYPICAL CHARACTERISTICS (TA = 25°C)



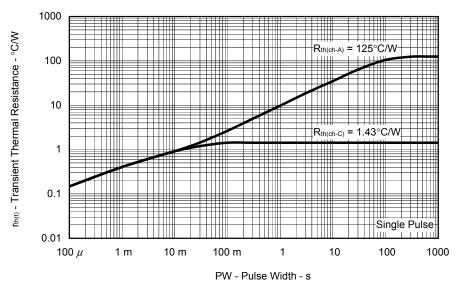




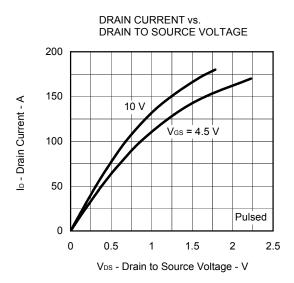




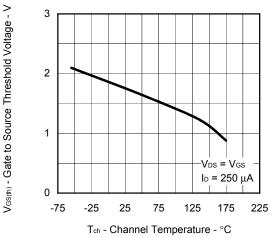
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

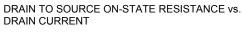


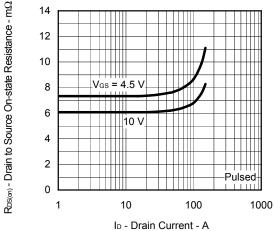
Data Sheet D19794EJ1V0DS



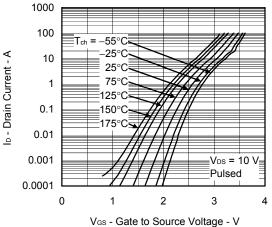
GATE TO SOURCE THRESHOLD VOLTAGE vs. CHANNEL TEMPERATURE





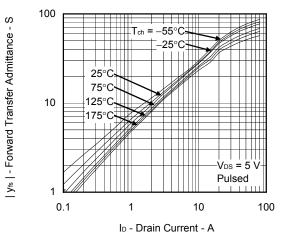




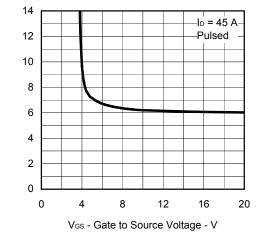


VGS - Gale to Source voltage - v

FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

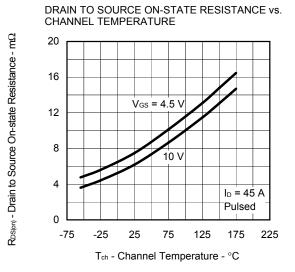




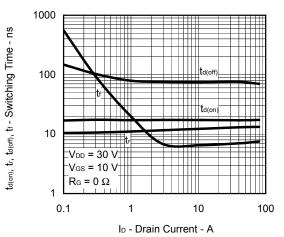


Data Sheet D19794EJ1V0DS

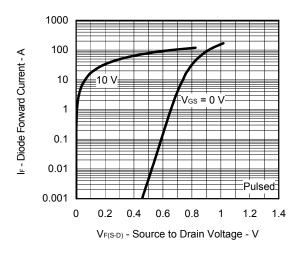
 $R_{DS(on)}$ - Drain to Source On-state Resistance - $m\Omega$

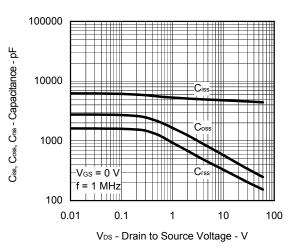


SWITCHING CHARACTERISTICS



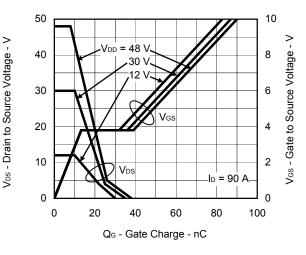
SOURCE TO DRAIN DIODE FORWARD VOLTAGE

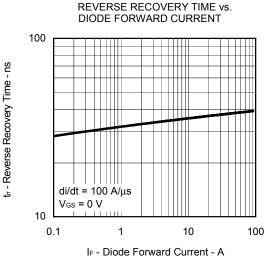




CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE

DYNAMIC INPUT/OUTPUT CHARACTERISTICS



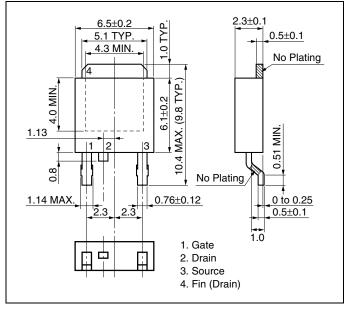


CTERISTICS

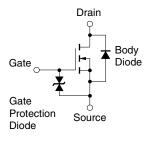
5

PACKAGE DRAWING (Unit: mm)

TO-252 (MP-3ZP)



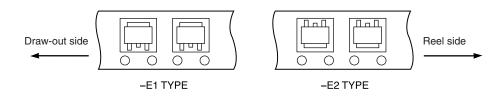
EQUIVALENT CIRCUIT



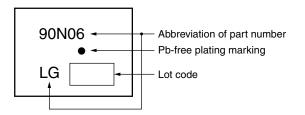
Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

TAPE INFORMATION

There are two types (-E1, -E2) of taping depending on the direction of the device.



MARKING INFORMATION



RECOMMENDED SOLDERING CONDITIONS

The NP90N06VLG should be soldered and mounted under the following recommended conditions.

For soldering methods and conditions other than those recommended below, please contact an NEC Electronics sales representative.

For technical information, see the following website.

Semiconductor Device Mount Manual (http://www.necel.com/pkg/en/mount/index.html)

Soldering Method	Soldering Conditions	Recommended Condition Symbol
Infrared reflow	Maximum temperature (Package's surface temperature): 260°C or below	IR60-00-3
	Time at maximum temperature: 10 seconds or less	
	Time of temperature higher than 220°C: 60 seconds or less	
	Preheating time at 160 to 180°C: 60 to 120 seconds	
	Maximum number of reflow processes: 3 times	
	Maximum chlorine content of rosin flux (percentage mass): 0.2% or less	
Partial heating	Maximum temperature (Pin temperature): 350°C or below	P350
	Time (per side of the device): 3 seconds or less	
	Maximum chlorine content of rosin flux: 0.2% (wt.) or less	

Caution Do not use different soldering methods together (except for partial heating).

- The information in this document is current as of May, 2009. The information is subject to change without notice. For actual design-in, refer to the latest publications of NEC Electronics data sheets, etc., for the most up-to-date specifications of NEC Electronics products. Not all products and/or types are available in every country. Please check with an NEC Electronics sales representative for availability and additional information.
- No part of this document may be copied or reproduced in any form or by any means without the prior written consent of NEC Electronics. NEC Electronics assumes no responsibility for any errors that may appear in this document.
- NEC Electronics does not assume any liability for infringement of patents, copyrights or other intellectual property rights of third parties by or arising from the use of NEC Electronics products listed in this document or any other liability arising from the use of such products. No license, express, implied or otherwise, is granted under any patents, copyrights or other intellectual property rights of NEC Electronics or others.
- Descriptions of circuits, software and other related information in this document are provided for illustrative purposes in semiconductor product operation and application examples. The incorporation of these circuits, software and information in the design of a customer's equipment shall be done under the full responsibility of the customer. NEC Electronics assumes no responsibility for any losses incurred by customers or third parties arising from the use of these circuits, software and information.
- While NEC Electronics endeavors to enhance the quality and safety of NEC Electronics products, customers agree and acknowledge that the possibility of defects thereof cannot be eliminated entirely. In addition, NEC Electronics products are not taken measures to prevent radioactive rays in the product design. When customers use NEC Electronics products with their products, customers shall, on their own responsibility, incorporate sufficient safety measures such as redundancy, fire-containment and anti-failure features to their products in order to avoid risks of the damages to property (including public or social property) or injury (including death) to persons, as the result of defects of NEC Electronics products.
- NEC Electronics products are classified into the following three quality grades: "Standard", "Special" and "Specific".

The "Specific" quality grade applies only to NEC Electronics products developed based on a customerdesignated "quality assurance program" for a specific application. The recommended applications of an NEC Electronics product depend on its quality grade, as indicated below. Customers must check the quality grade of each NEC Electronics product before using it in a particular application.

- "Standard": Computers, office equipment, communications equipment, test and measurement equipment, audio and visual equipment, home electronic appliances, machine tools, personal electronic equipment and industrial robots.
- "Special": Transportation equipment (automobiles, trains, ships, etc.), traffic control systems, anti-disaster systems, anti-crime systems, safety equipment and medical equipment (not specifically designed for life support).
- "Specific": Aircraft, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems and medical equipment for life support, etc.

The quality grade of NEC Electronics products is "Standard" unless otherwise expressly specified in NEC Electronics data sheets or data books, etc. If customers wish to use NEC Electronics products in applications not intended by NEC Electronics, they must contact an NEC Electronics sales representative in advance to determine NEC Electronics' willingness to support a given application.

(Note)

- (1) "NEC Electronics" as used in this statement means NEC Electronics Corporation and also includes its majority-owned subsidiaries.
- (2) "NEC Electronics products" means any product developed or manufactured by or for NEC Electronics (as defined above).